

<b>Notice of References Cited</b>	Application/Control No. 10/655,308	Applicant(s)/Patent Under Reexamination KANG, SUNG-TAEG	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,747,310	06-2004	Fan et al.	257/320
	B	US-6,657,893	12-2003	Takahashi et al.	365/185.15
	C	US-6,172,397	01-2001	Oonakado et al.	257/321
	D	US-5,780,893	07-1998	Sugaya, Fumitaka	257/318
	E	US-5,559,735	09-1996	Ono et al.	365/185.3
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.